**Product data sheet** 

## 1. General description

The 74LVT16374A; 74LVTH16374A is a 16-bit edge-triggered D-type flip-flop with 3-state outputs. The device can be used as two 8-bit flip-flops or one 16-bit flip-flop. The device features two clocks (1CP and 2CP) and two output enables (1OE and 2OE), each controlling 8-bits. The flip-flops will store the state of their individual D-inputs that meet the set-up and hold time requirements on the LOW-to-HIGH clock (nCP) transition. A HIGH on nOE causes the outputs to assume a high-impedance OFF-state. Operation of the nOE input does not affect the state of the flip-flops.

### 2. Features and benefits

- 16-bit edge-triggered flip-flop
- 3-state buffers
- Output capability: +64 mA and -32 mA
- Wide supply voltage range from 2.7 to 3.6 V
- Overvoltage tolerant inputs to 5.5 V
- BiCMOS high speed and output drive
- Direct interface with TTL levels
- Input and output interface capability to systems at 5 V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs. (74LVTH16374A only)
- Live insertion and extraction permitted
- Power-up reset
- Power-up 3-state
- No bus current loading when output is tied to 5 V bus
- I<sub>OFF</sub> circuitry provides partial Power-down mode operation
- Latch-up performance exceeds 500 mA per JESD 78 Class II Level B
- Complies with JEDEC standard JESD8C (2.7 V to 3.6 V)
- ESD protection:
  - HBM: ANSI/ESDA/JEDEC JS-001 class 2 exceeds 2000 V
  - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- Specified from -40 °C to 85 °C

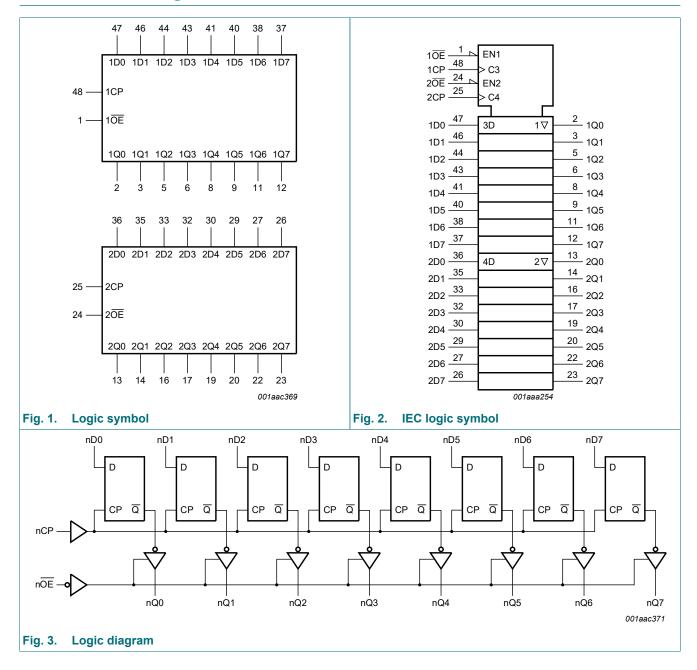
# 3. Ordering information

### **Table 1. Ordering information**

Type number	Package					
	Temperature range	Name	Description	Version		
74LVT16374ADGG 74LVTH16374ADGG	-40 °C to +85 °C		plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1		



# 4. Functional diagram

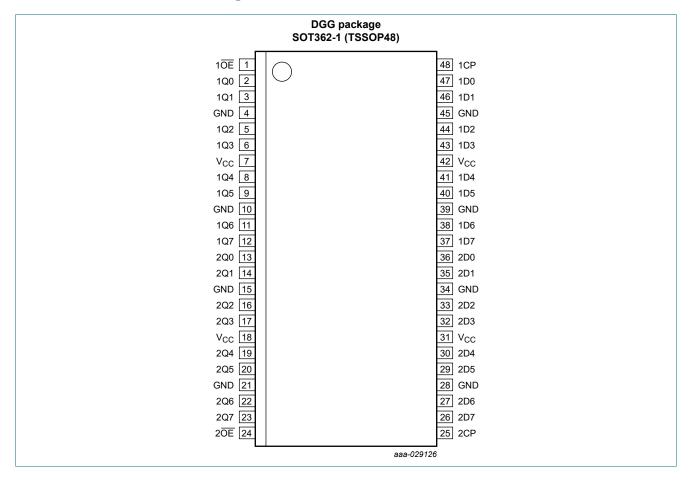


**Product data sheet** 

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# 5. Pinning information

## 5.1. Pinning



## 5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
1 <del>OE</del> , 2 <del>OE</del>	1, 24	output enable input (active LOW)
1CP, 2CP	48, 25	clock input
1Q0, 1Q1, 1Q2, 1Q3, 1Q4, 1Q5, 1Q6, 1Q7	2, 3, 5, 6, 8, 9, 11, 12	data output
2Q0, 2Q1, 2Q2, 2Q3, 2Q4, 2Q5, 2Q6, 2Q7	13, 14, 16, 17, 19, 20, 22, 23	data output
GND	4, 10, 15, 21, 28, 34, 39, 45	ground (0 V)
Vcc	7, 18, 31, 42	supply voltage
1D0, 1D1, 1D2, 1D3, 1D4, 1D5, 1D6, 1D7	47, 46, 44, 43, 41, 40, 38, 37	data input
2D0, 2D1, 2D2, 2D3, 2D4, 2D5, 2D6, 2D7	36, 35, 33, 32, 30, 29, 27, 26	data input

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## 6. Functional description

#### **Table 3. Function table**

H = HIGH voltage level; h = HIGH voltage level one set-up time prior to the HIGH-to-LOW clock transition;

L = LOW voltage level; I = LOW voltage level one set-up time prior to the HIGH-to-LOW clock transition;

NC = no change; X = don't care;

Z = high-impedance OFF-state; ↑ = LOW-to-HIGH clock transition.

Operating mode	Input			Internal register	Output
	nŌĒ	nCP	nDn		nQ0 to nQ7
Load and read register	L	1	I	L	L
	L	1	h	Н	Н
Hold	L	NC	X	NC	NC
Disable outputs	Н	NC	X	NC	Z
	Н	1	nDn	nDn	Z

## 7. Limiting values

#### **Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage			-0.5	+4.6	V
VI	input voltage		[1]	-0.5	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	[1]	-0.5	+7.0	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V		-50	-	mA
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V		-50	-	mA
Io	output current	output in LOW-state		-	128	mA
		output in HIGH-state		-64	-	mA
T <sub>stg</sub>	storage temperature			-65	+150	°C
Tj	junction temperature		[2]	-	150	°C
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = -40 °C to +85 °C		-	500	mW

<sup>[1]</sup> The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

<sup>[2]</sup> The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

# 8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		2.7	-	3.6	V
VI	input voltage		0	-	5.5	V
V <sub>IH</sub>	HIGH-level input voltage		2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage		-	-	0.8	V
I <sub>OH</sub>	HIGH-level output current		-32	-	-	mA
I <sub>OL</sub>	LOW-level output current	none	-	-	32	mA
		current duty cycle ≤ 50 %; f <sub>i</sub> ≥ 1 kHz	-	-	64	mA
T <sub>amb</sub>	ambient temperature	in free-air	-40	-	+85	°C
Δt/ΔV	input transition rise and fall rate	outputs enabled	-	-	10	ns/V

## 9. Static characteristics

### **Table 6. Static characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T <sub>amb</sub> =	-40 °C to +	85 °C	Unit
			Min	Typ [1] Max		
V <sub>IK</sub>	input clamping voltage	V <sub>CC</sub> = 2.7 V; I <sub>IK</sub> = -18 mA	-1.2	-0.85	-	V
V <sub>OH</sub>	HIGH-level output voltage	I <sub>OH</sub> = -100 μA; V <sub>CC</sub> = 2.7 V to 3.6 V	V <sub>CC</sub> - 0.2	V <sub>CC</sub>	-	V
		I <sub>OH</sub> = -8 mA; V <sub>CC</sub> = 2.7 V	2.4	2.5	-	V
		I <sub>OH</sub> = -32 mA; V <sub>CC</sub> = 3.0 V	2.0	2.3	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>CC</sub> = 2.7 V				
		I <sub>OL</sub> = 100 μA	-	0.07	0.2	V
		I <sub>OL</sub> = 24 mA	-	0.3	0.5	V
		V <sub>CC</sub> = 3.0 V				
		I <sub>OL</sub> = 16 mA	-	0.25	0.4	V
		I <sub>OL</sub> = 32 mA	-	0.3	0.5	V
		I <sub>OL</sub> = 64 mA	-	0.4	0.55	V
V <sub>OL(pu)</sub>	power-up LOW-level output voltage	$V_{CC} = 3.6 \text{ V; } I_O = 1 \text{ mA;}$ [2] $V_I = V_{CC} \text{ or GND}$	-	0.1	0.55	V
l <sub>l</sub>	input leakage current	control pins				
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = V <sub>CC</sub> or GND	-	0.1	±1	μA
		V <sub>CC</sub> = 0 V or 3.6 V; V <sub>I</sub> = 5.5 V	-	0.4	10	μA
		input data pins [3]				
		V <sub>CC</sub> = 0 V or 3.6 V; V <sub>I</sub> = 5.5 V	-	0.4	10	μA
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = V <sub>CC</sub>	-	0.1	1	μA
		V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 0 V	-5	-0.4	-	μΑ
I <sub>OFF</sub>	power-off leakage current	$V_{CC} = 0 \text{ V}; V_{I} \text{ or } V_{O} = 0 \text{ V to } 4.5 \text{ V}$	-	0.1	±100	μΑ
I <sub>BHL</sub>	bus hold LOW current	V <sub>CC</sub> = 3 V; V <sub>I</sub> = 0.8 V	75	135	-	μA
I <sub>BHH</sub>	bus hold HIGH current	V <sub>CC</sub> = 3 V; V <sub>I</sub> = 2.0 V	-	-135	-75	μA
I <sub>BHLO</sub>	bus hold LOW overdrive current	input data pins; $V_I = 0 \text{ V to } 3.6 \text{ V};$ [4] $V_{CC} = 3.6 \text{ V}$	500	-	-	μΑ

Symbol	Parameter	Conditions		T <sub>amb</sub> =	-40 °C to +	·85 °C	Unit
				Min	Typ [1]	Max	
Івнно	bus hold HIGH overdrive input data pins; $V_I = 0 \text{ V}$ to 3.6 V; [4] current $V_{CC} = 3.6 \text{ V}$		[4]	-	-	-500	μΑ
I <sub>LO</sub>	output leakage current	output in HIGH-state when $V_O > V_{CC}$ ; $V_O = 5.5 \text{ V}$ ; $V_{CC} = 3.0 \text{ V}$		-	50	125	μΑ
I <sub>O(pu/pd)</sub>	power-up/power-down output current	$V_{CC} \le 1.2 \text{ V}; V_O = 0.5 \text{ V to } V_{CC};$ $V_I = \text{GND or } V_{CC}; \text{ nOE} = \text{don't care}$	[5]	-	1	±100	μA
l <sub>OZ</sub>	OFF-state output current	$V_{CC}$ = 3.6 V; $V_I$ = $V_{IH}$ or $V_{IL}$					
		output HIGH: V <sub>O</sub> = 3.0 V		-	0.5	5	μA
		output LOW: V <sub>O</sub> = 0.5 V		-5	0.5	-	μA
I <sub>CC</sub>	supply current	$V_{CC}$ = 3.6 V; $V_I$ = GND or $V_{CC}$ ; $I_O$ = 0 A					
		outputs HIGH		-	0.07	0.12	mA
		outputs LOW		-	4.0	6.0	mA
		outputs disabled	[6]	-	0.07	0.12	mA
Δl <sub>CC</sub>	additional supply current	per input pin; $V_{CC}$ = 3.0 V to 3.6 V; one input at $V_{CC}$ - 0.6 V, other inputs at $V_{CC}$ or GND		-	0.1	0.2	mA
Cı	input capacitance	input pins; V <sub>I</sub> = 0 V or 3.0 V		-	3	-	pF
Co	output capacitance	output pins nQn; outputs disabled; V <sub>O</sub> = 0 V or V <sub>CC</sub>		-	9	-	pF

- Typical values are measured at  $V_{CC}$  = 3.3 V and at  $T_{amb}$  = 25 °C.
- [2] For valid test results, data must not be loaded into the flips-flops (or latches) after applying power.
- [3] Unused pins at V<sub>CC</sub> or GND.
- [4] This is the bus hold overdrive current required to force the input to the opposite logic state.
- [5] This parameter is valid for any  $V_{CC}$  between 0 V and 1.2 V with a transition time of up to 10 ms. From  $V_{CC} = 1.2$  V to  $V_{CC} = 3.3$  V  $\pm$  0.3 V a transition time of 100  $\mu$ s is permitted. This parameter is valid for  $T_{amb} = 25$  °C only.
- [6]  $I_{CC}$  is measured with outputs pulled to  $V_{CC}$  or GND.
- [7] This is the increase in supply current for each input at the specified voltage level other than V<sub>CC</sub> or GND.

## 10. Dynamic characteristics

### **Table 7. Dynamic characteristics**

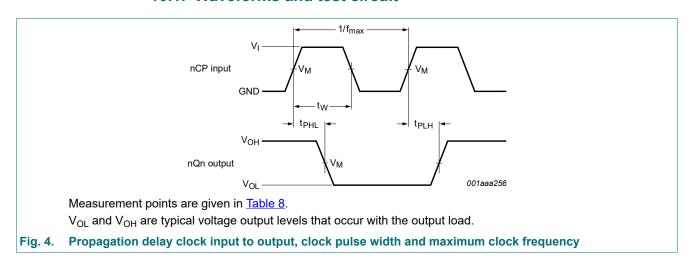
Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 7.

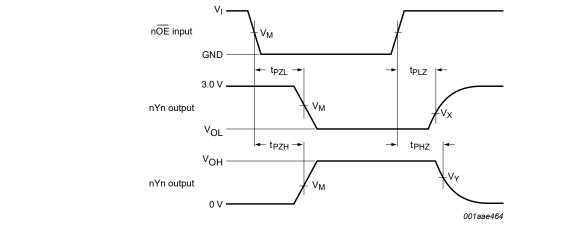
Symbol	Parameter	Conditions	T <sub>amb</sub> =	T <sub>amb</sub> = -40 °C to +85 °C			
			Min	Typ [1]	Max		
f <sub>max</sub>	maximum frequency	nCP; V <sub>CC</sub> = 3.3 V ± 0.3 V; see <u>Fig. 4</u>	150	-	-	MHz	
t <sub>PLH</sub>	LOW to HIGH propagation	nCP to nQn; see Fig. 4					
	delay	V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	2.9	5.0	ns	
		V <sub>CC</sub> = 2.7 V	-	-	5.6	ns	
t <sub>PHL</sub>	HIGH to LOW propagation delay	nCP to nQn; see Fig. 4					
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	3.0	5.0	ns	
		V <sub>CC</sub> = 2.7 V	-	-	5.6	ns	
t <sub>PZH</sub>	OFF-state to HIGH	nOE to nQn; see Fig. 5					
	propagation delay	V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	3.2	4.8	ns	
		V <sub>CC</sub> = 2.7 V	-	-	6.0	ns	
t <sub>PZL</sub>	OFF-state to LOW	nOE to nQn; see Fig. 5					
	propagation delay	V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	3.0	4.6	ns	
		V <sub>CC</sub> = 2.7 V	-	-	5.2	ns	

Symbol	Parameter	Conditions	T <sub>amb</sub> :	= -40 °C to	+85 °C	Unit
			Min	Typ [1]	Max	
t <sub>PHZ</sub>	HIGH to OFF-state	nOE to nQn; see Fig. 5				
	propagation delay	V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	3.9	5.4	ns
		V <sub>CC</sub> = 2.7 V	-	-	6.0	ns
t <sub>PLZ</sub>	LOW to OFF-state	nOE to nQn; see Fig. 5				
	propagation delay	V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	3.4	4.6	ns
		V <sub>CC</sub> = 2.7 V	-	-	5.0	ns
t <sub>su</sub>	set-up time	nDn to nCP; HIGH or LOW; see Fig. 6				
		V <sub>CC</sub> = 3.3 V ± 0.3 V	2.0	0.7	-	ns
		V <sub>CC</sub> = 2.7 V	2.0	-	-	ns
t <sub>h</sub>	hold time	nDn to nCP; HIGH or LOW; see Fig. 6				
		V <sub>CC</sub> = 3.3 V ± 0.3 V	0.8	0	-	ns
		V <sub>CC</sub> = 2.7 V	0.1	-	-	ns
t <sub>W</sub>	pulse width	nCP HIGH; see Fig. 4				
		V <sub>CC</sub> = 3.3 V ± 0.3 V	1.5	0.6	-	ns
		V <sub>CC</sub> = 2.7 V	1.5	-	-	ns
		nCP LOW; see Fig. 4				
		V <sub>CC</sub> = 3.3 V ± 0.3 V	3.0	1.6	-	ns
		V <sub>CC</sub> = 2.7 V	3.0	-	-	ns

[1] All typical values are measured at  $V_{CC}$  = 3.3 V and  $T_{amb}$  = 25 °C.

## 10.1. Waveforms and test circuit

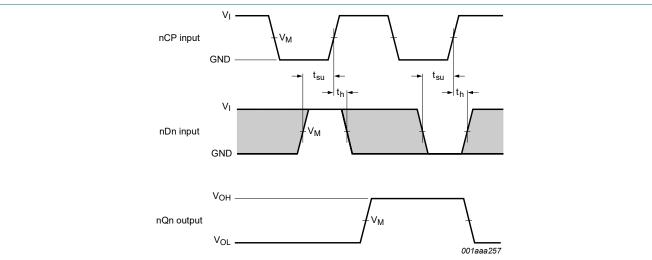




Measurements points are given in Table 8.

 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical voltage output levels that occur with the output load.

Fig. 5. Enable and disable times



Measurement points are given in Table 8.

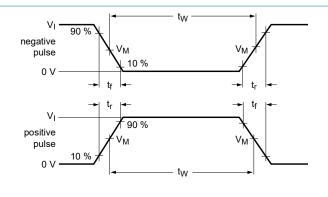
 $\ensuremath{V_{\text{OL}}}$  and  $\ensuremath{V_{\text{OH}}}$  are typical voltage output levels that occur with the output load.

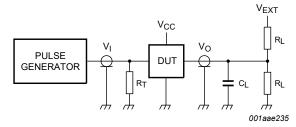
The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 6. Data set-up and hold times

**Table 8. Measurement points** 

Input	Output	utput				
V <sub>M</sub>	V <sub>M</sub>	V <sub>X</sub>	V <sub>Y</sub>			
1.5 V	1.5 V	V <sub>OL</sub> + 0.3 V	V <sub>OH</sub> - 0.3 V			





Test data is given in Table 9.

Definitions test circuit:

R<sub>L</sub> = Load resistance;

C<sub>L</sub> = Load capacitance including jig and probe capacitance;

 $R_{T}$  = Termination resistance should be equal to output impedance  $Z_{o}$  of the pulse generator;

V<sub>EXT</sub> = Test voltage for switching times.

Fig. 7. Test circuit for measuring switching times

Table 9. Test data

Input			Load		V <sub>EXT</sub>			
VI	fi	t <sub>W</sub>	t <sub>r</sub> , t <sub>f</sub>	CL	$R_L$	t <sub>PHZ</sub> , t <sub>PZH</sub>	t <sub>PLZ</sub> , t <sub>PZL</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>
2.7 V	≤ 10 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	GND	6 V	open

# 11. Package outline

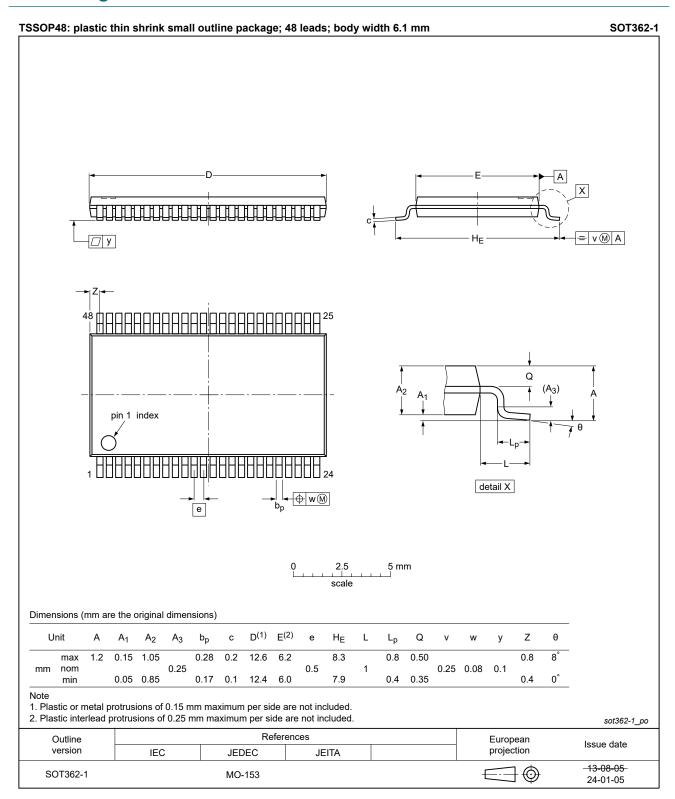


Fig. 8. Package outline SOT362-1 (TSSOP48)

## 12. Abbreviations

#### **Table 10. Abbreviations**

Acronym	Description			
ANSI	American National Standards Institute			
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor			
CDM	Charge Device Model			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
ESDA	ElectroStatic Discharge Association			
НВМ	Human Body Model			
JEDEC	Joint Electron Device Engineering Council			
TTL	Transistor-Transistor Logic			

# 13. Revision history

## Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
74LVT_LVTH16374A v.14	20240708	Product data sheet	-	74LVT_LVTH16374A v.13		
Modifications:	Section 2: E	<u>Section 2</u> : ESD specification updated according to the latest JEDEC standard.				
74LVT_LVTH16374A v.13	20240321	Product data sheet	-	74LVT_LVTH16374A v.12		
Modifications:	• Fig. 8: Upda	Fig. 8: Updated package outline drawing SOT362-1 (TSSOP48).				
74LVT_LVTH16374A v.12	20210806	Product data sheet	-	74LVT_LVTH16374A v.11		
Modifications:	<ul> <li>Type number 74LVT16374ADL (SOT370-1/SSOP48) removed.</li> <li>Section 1 and Section 2 updated.</li> <li>Section 7: Derating value for Ptot total power dissipation removed.</li> </ul>					
74LVT_LVTH16374A v.11	20190205	Product data sheet	-	74LVT_LVTH16374A v.10		
Modifications:	guidelines o Legal texts I Type number 74LVTH163	Logar toxic have been adapted to the new company hame where appropriate.				
74LVT_LVTH16374A v.10	20120402	Product data sheet	-	74LVT_LVTH16374A v.9		
Modifications:	For type number 74LVTH16374ABX the sot code has changed to SOT1134-2.					
74LVT_LVTH16374A v.9	20111122	Product data sheet	-	74LVT_LVTH16374A v.8		
Modifications:	Legal pages updated.					
74LVT_LVTH16374A v.8	20110620	Product data sheet	-	74LVT_LVTH16374A v.7		
74LVT_LVTH16374A v.7	20100322	Product data sheet	-	74LVT_LVTH16374A v.6		
74LVT_LVTH16374A v.6	20100118	product data sheet	-	74LVT16374A v.5		
74LVT16374A v.5	20040916	product data sheet	-	74LVT16374A v.4		
74LVT16374A v.4	20021101	product specification	-	74LVT16374A v.3		
74LVT16374A v.3	19991018	product specification	-	74LVT16374A v.2		
74LVT16374A v.2	19980219	product specification	-	-		

## 14. Legal information

#### **Data sheet status**

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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### 3.3 V 16-bit edge-triggered D-type flip-flop; 3-state

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